

SKiM<sup>®</sup> 4

## Trench IGBT Modules

### SKiM301MLI12E4

#### Features

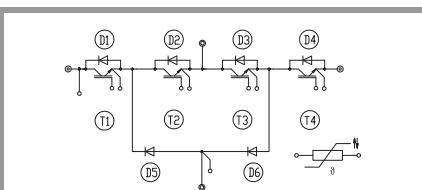
- IGBT 4 Trench Gate Technology
- Solder technology
- $V_{CE(sat)}$  with positive temperature coefficient
- Low inductance case
- Insulated by Al<sub>2</sub>O<sub>3</sub> DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to 6 x I<sub>C</sub>
- Integrated temperature sensor

#### Typical Applications

- UPS
- 3 Level Inverter

#### Remarks\*

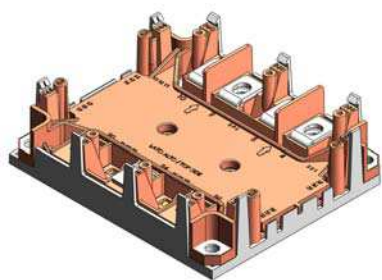
- Case temperature limited to T<sub>s</sub> = 125°C max; T<sub>c</sub> = T<sub>s</sub> (for baseplateless modules)
- Recommended T<sub>jop</sub> = -40 ... +150°C
- IGBT1 : outer IGBTs T1 & T4
- IGBT2 : inner IGBTs T2 & T3
- Diode1 : outer diodes D1 & D4
- Diode2 : inner diodes D2 & D3
- Diode5 : clamping diodes D5 & D6



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#### Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
<b>IGBT1</b>			
V <sub>CEs</sub>	T <sub>j</sub> = 25 °C	1200	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	311
		T <sub>s</sub> = 70 °C	252
I <sub>Cnom</sub>		300	A
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>	900	A
V <sub>GES</sub>		-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 800 V, V <sub>GE</sub> ≤ 15 V, T <sub>j</sub> = 150 °C, V <sub>CEs</sub> ≤ 1200 V	10	µs
T <sub>j</sub>		-40 ... 175	°C
<b>IGBT2</b>			
V <sub>CEs</sub>	T <sub>j</sub> = 25 °C	1200	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	311
		T <sub>s</sub> = 70 °C	252
I <sub>Cnom</sub>		300	A
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>	900	A
V <sub>GES</sub>		-20 ... 20	V
t <sub>psc</sub>	V <sub>CC</sub> = 800 V, V <sub>GE</sub> ≤ 15 V, T <sub>j</sub> = 150 °C, V <sub>CEs</sub> ≤ 1200 V	10	µs
T <sub>j</sub>		-40 ... 175	°C
<b>Diode1</b>			
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C	1200	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	282
		T <sub>s</sub> = 70 °C	223
I <sub>Fnom</sub>		300	A
I <sub>FRM</sub>	I <sub>FRM</sub> = 3 x I <sub>Fnom</sub>	900	A
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 25 °C	1485	A
T <sub>j</sub>		-40 ... 175	°C
<b>Diode2</b>			
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C	1200	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	282
		T <sub>s</sub> = 70 °C	223
I <sub>Fnom</sub>		300	A
I <sub>FRM</sub>	I <sub>FRM</sub> = 3 x I <sub>Fnom</sub>	900	A
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 25 °C	1485	A
T <sub>j</sub>		-40 ... 175	°C
<b>Diode5</b>			
V <sub>RRM</sub>	T <sub>j</sub> = 25 °C	1200	V
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	219
		T <sub>s</sub> = 70 °C	172
I <sub>Fnom</sub>		300	A
I <sub>FRM</sub>	I <sub>FRM</sub> = 3 x I <sub>Fnom</sub>	900	A
I <sub>FSM</sub>	10 ms, sin 180°, T <sub>j</sub> = 25 °C	1620	A
T <sub>j</sub>		-40 ... 175	°C
<b>Module</b>			
I <sub>t(RMS)</sub>		400	A
T <sub>stg</sub>		-40 ... 125	°C
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min	2500	V



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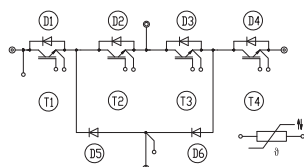
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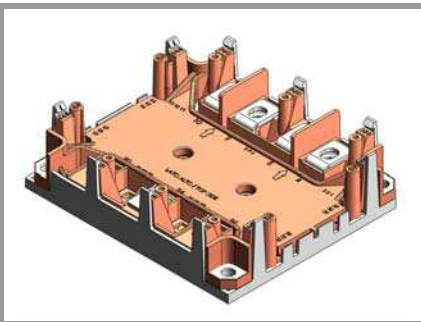
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>IGBT1</b>						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 300 A V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		1.80	2.05	V
		T <sub>j</sub> = 150 °C		2.20	2.40	V
V <sub>CE0</sub>	chipelevel	T <sub>j</sub> = 25 °C		0.80	0.90	V
		T <sub>j</sub> = 150 °C		0.70	0.80	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		3.3	3.8	mΩ
		T <sub>j</sub> = 150 °C		5.0	5.3	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 11.4 mA		5	5.8	6.5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V, T <sub>j</sub> = 25 °C				4	mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		18.45		nF
C <sub>oes</sub>		f = 1 MHz		1.215		nF
C <sub>res</sub>		f = 1 MHz		1.035		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 15 V...+ 15 V			2400		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			2.5		Ω
t <sub>d(on)</sub>	V <sub>CE</sub> = 600 V	T <sub>j</sub> = 150 °C		182		ns
t <sub>r</sub>	I <sub>C</sub> = 300 A	T <sub>j</sub> = 150 °C		52		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		22.2		mJ
t <sub>d(off)</sub>	R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		446		ns
t <sub>f</sub>	R <sub>G off</sub> = 1 Ω	T <sub>j</sub> = 150 °C		98		ns
E <sub>off</sub>	di/dt <sub>on</sub> = 5700 A/μs di/dt <sub>off</sub> = 2600 A/μs	T <sub>j</sub> = 150 °C		33.9		mJ
R <sub>th(j-s)</sub>	per IGBT			0.19		K/W
<b>IGBT2</b>						
V <sub>CE(sat)</sub>	I <sub>C</sub> = 300 A V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		1.80	2.05	V
		T <sub>j</sub> = 150 °C		2.20	2.40	V
V <sub>CE0</sub>	chipelevel	T <sub>j</sub> = 25 °C		0.80	0.90	V
		T <sub>j</sub> = 150 °C		0.70	0.80	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chipelevel	T <sub>j</sub> = 25 °C		3.3	3.8	mΩ
		T <sub>j</sub> = 150 °C		5.0	5.3	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 11.4 mA		5	5.8	6.5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 1200 V, T <sub>j</sub> = 25 °C				4	mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		18.45		nF
C <sub>oes</sub>		f = 1 MHz		1.215		nF
C <sub>res</sub>		f = 1 MHz		1.035		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 15 V...+ 15 V			2400		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			2.5		Ω
t <sub>d(on)</sub>	V <sub>CE</sub> = 600 V	T <sub>j</sub> = 150 °C		184		ns
t <sub>r</sub>	I <sub>C</sub> = 300 A	T <sub>j</sub> = 150 °C		59		ns
E <sub>on</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		11		mJ
t <sub>d(off)</sub>	R <sub>G on</sub> = 1 Ω	T <sub>j</sub> = 150 °C		457		ns
t <sub>f</sub>	R <sub>G off</sub> = 1 Ω	T <sub>j</sub> = 150 °C		73		ns
E <sub>off</sub>	di/dt <sub>on</sub> = 4960 A/μs di/dt <sub>off</sub> = 1840 A/μs	T <sub>j</sub> = 150 °C		35.8		mJ
R <sub>th(j-s)</sub>	per IGBT			0.19		K/W



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- Solder technology
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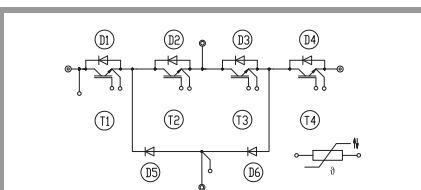
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- 3 Level Inverter

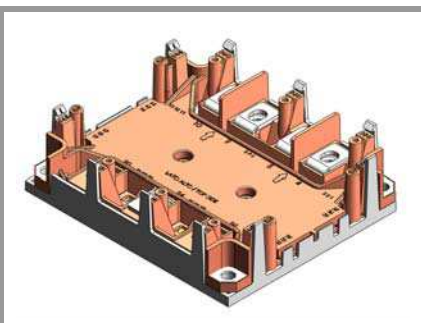
#### Remarks\*

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- Recommended T<sub>jop</sub> = -40 ... +150°C
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Diode1</b>						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 25 °C		2.20	2.52	V
		chipelevel	T <sub>j</sub> = 150 °C	2.15	2.47	V
V <sub>F0</sub>	chipelevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chipelevel	T <sub>j</sub> = 25 °C		3.0	3.4	mΩ
		T <sub>j</sub> = 150 °C		4.2	4.6	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 150 °C		320		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 5000 A/μs	T <sub>j</sub> = 150 °C		54.7		μC
E <sub>rr</sub>	V <sub>R</sub> = 600 V V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		21.8		mJ
R <sub>th(j-s)</sub>				0.24		K/W
<b>Diode2</b>						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 25 °C		2.20	2.52	V
		chipelevel	T <sub>j</sub> = 150 °C	2.15	2.47	V
V <sub>F0</sub>	chipelevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chipelevel	T <sub>j</sub> = 25 °C		3.0	3.4	mΩ
		T <sub>j</sub> = 150 °C		4.2	4.6	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 150 °C		320		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 5000 A/μs	T <sub>j</sub> = 150 °C		54.7		μC
E <sub>rr</sub>	V <sub>R</sub> = 600 V V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		-		mJ
R <sub>th(j-s)</sub>				0.24		K/W
<b>Diode5</b>						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 25 °C		2.14	2.46	V
		chipelevel	T <sub>j</sub> = 150 °C	2.07	2.38	V
V <sub>F0</sub>	chipelevel	T <sub>j</sub> = 25 °C		1.30	1.50	V
		T <sub>j</sub> = 150 °C		0.90	1.10	V
r <sub>F</sub>	chipelevel	T <sub>j</sub> = 25 °C		2.8	3.2	mΩ
		T <sub>j</sub> = 150 °C		3.9	4.3	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 300 A	T <sub>j</sub> = 150 °C		322		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 5700 A/μs	T <sub>j</sub> = 150 °C		53		μC
E <sub>rr</sub>	V <sub>R</sub> = 600 V V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 150 °C		24		mJ
R <sub>th(j-s)</sub>				0.36		K/W



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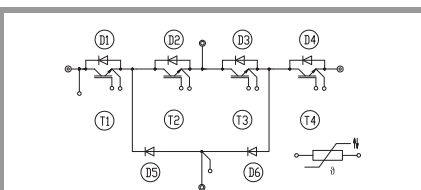
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Module</b>						
$L_{sCE1}$				32		nH
$L_{sCE2}$				25		nH
$R_{CC'+EE'}$	measured between terminal 4 and 24	$T_s = 25^\circ C$		0.4		m $\Omega$
		$T_s = 125^\circ C$		0.6		m $\Omega$
$M_s$	to heat sink M5		2		3	Nm
$M_t$	to terminals M6		4		5	Nm
$w$				317		g
<b>Temperature Sensor</b>						
$R_{100}$	$T_c = 100^\circ C$ ( $R_{25} = 5 \text{ k}\Omega$ )			$493 \pm 5\%$		$\Omega$
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$ ; $T[K]$			$3550 \pm 2\%$		K

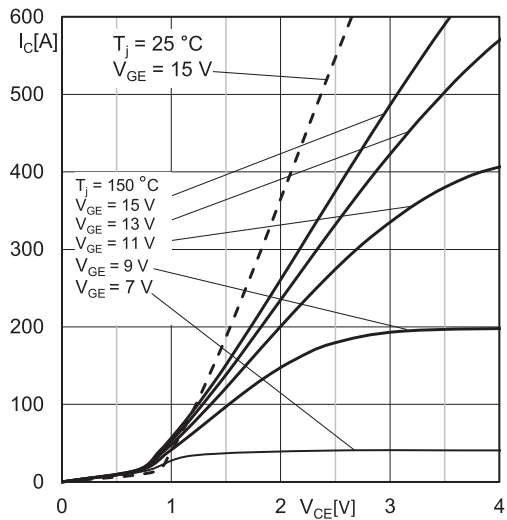


Fig. 1: Typ. IGBT1 output characteristic, incl.  $R_{CC'+EE'}$

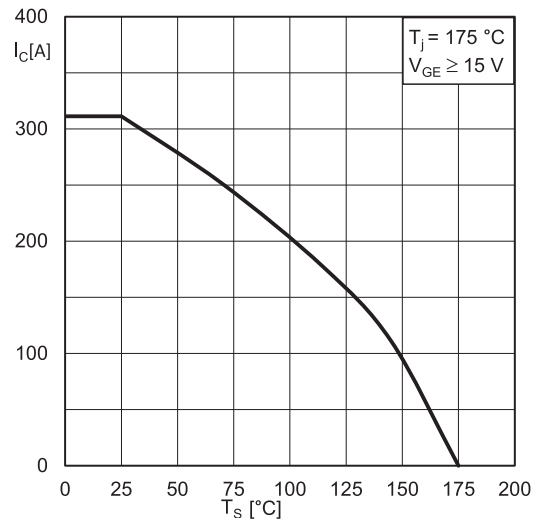


Fig. 2: IGBT1 rated current vs. Temperature  $I_C=f(T_s)$

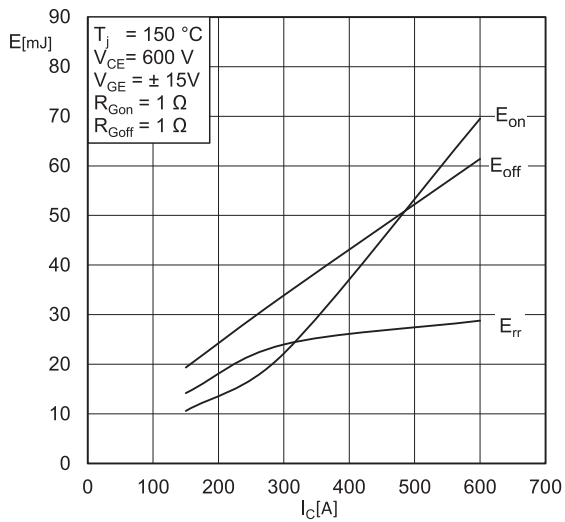


Fig. 3: Typ. IGBT1 & Diode5 turn-on /-off energy =  $f(I_C)$

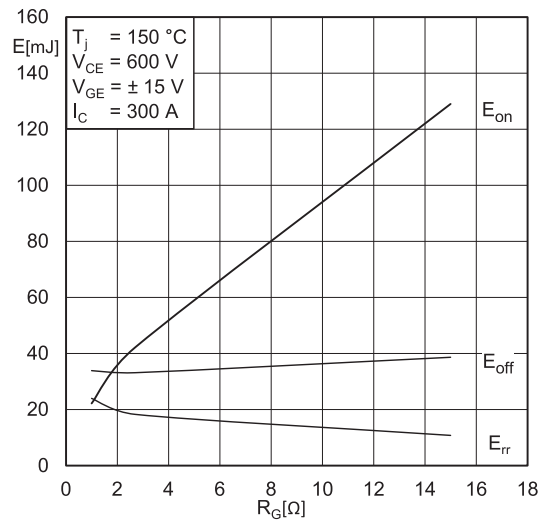


Fig. 4: Typ. IGBT1 & Diode5 turn-on /-off energy =  $f(R_G)$

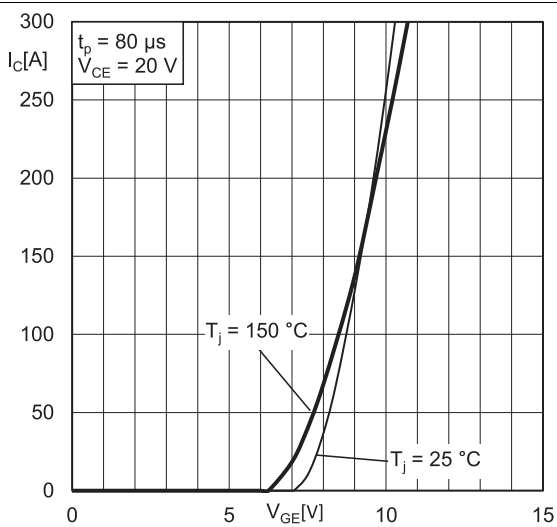


Fig. 5: Typ. IGBT1 transfer characteristic

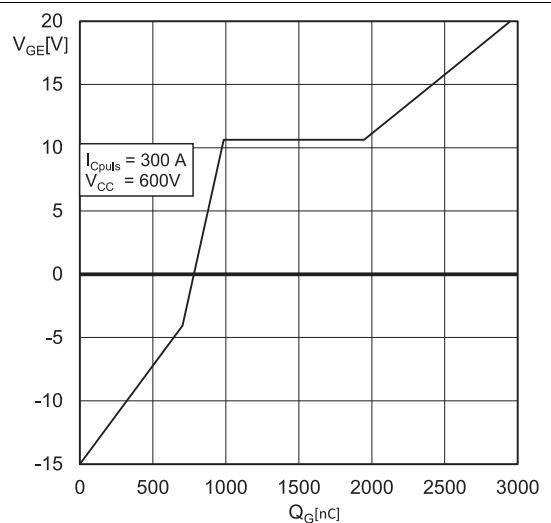


Fig. 6: Typ. IGBT1 gate charge characteristic

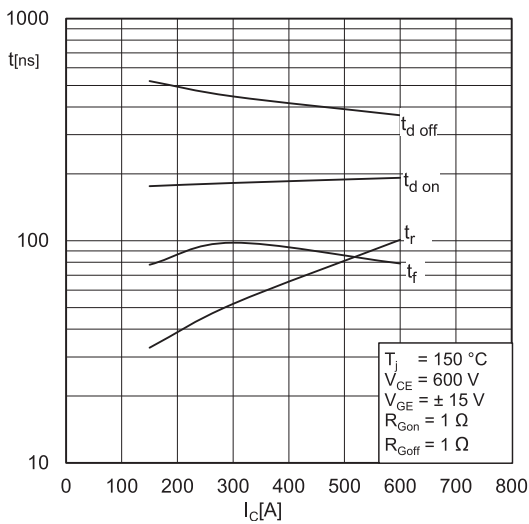


Fig. 7: Typ. IGBT1 switching times vs.  $I_C$

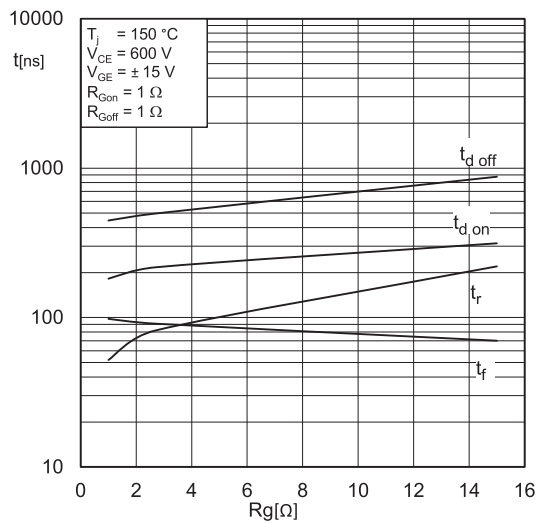


Fig. 8: Typ. IGBT1 switching times vs. gate resistor  $R_G$

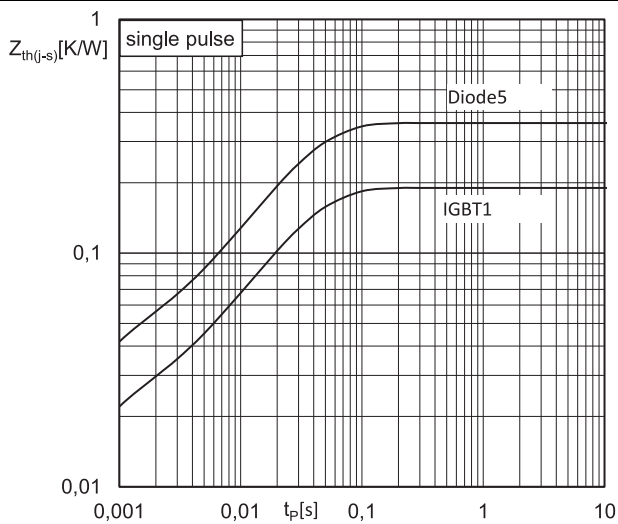


Fig. 9: Transient thermal impedance of IGBT1 & Diode5

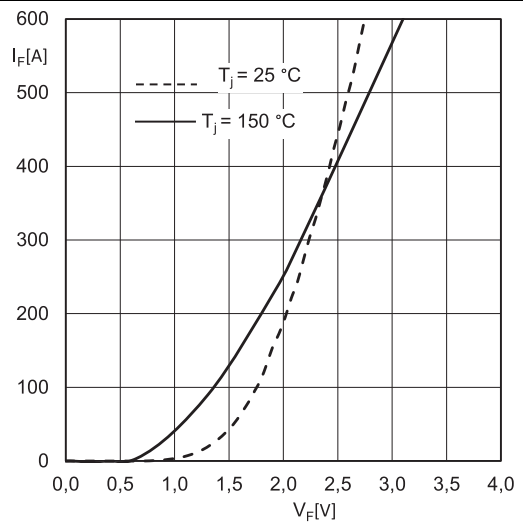


Fig. 10: Typ. Diode5 forward characteristic, incl.  $R_{CC+EE'}$

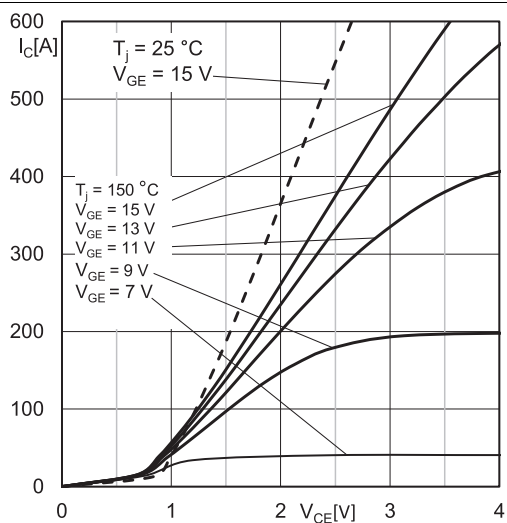


Fig. 13: Typ. IGBT2 output characteristic, incl.  $R_{CC+EE'}$

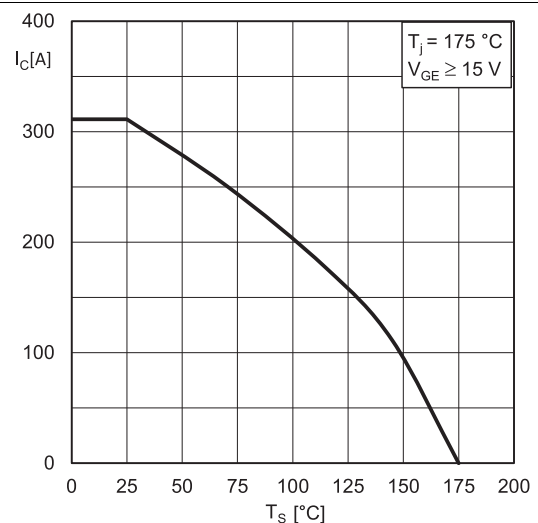


Fig. 14: IGBT2 Rated current vs. Temperature  $I_C = f(T_s)$

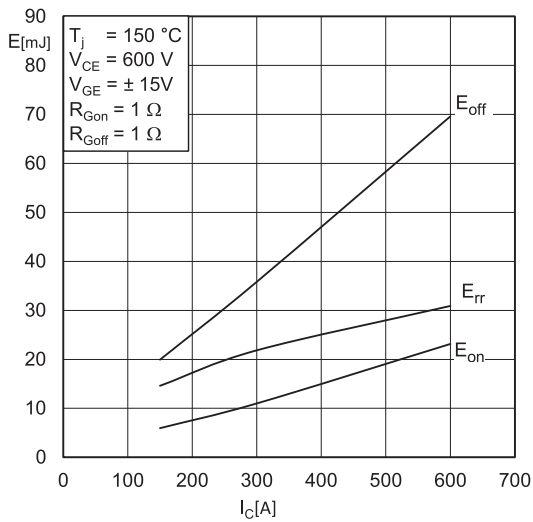


Fig. 15: Typ. IGBT2 & Diode1 turn-on /-off energy =  $f(I_c)$

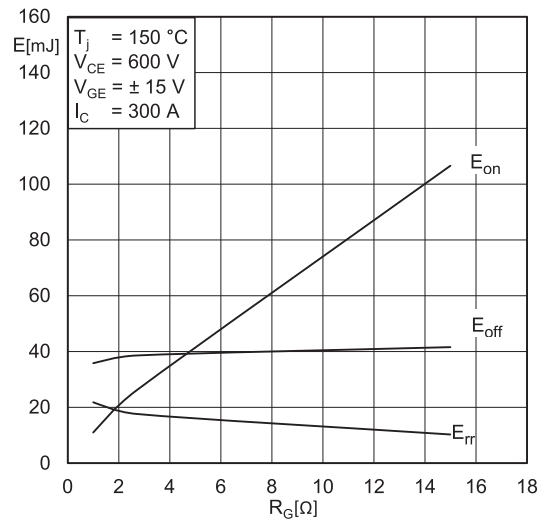


Fig. 16: Typ. IGBT2 & Diode1 turn-on / -off energy =  $f(R_G)$

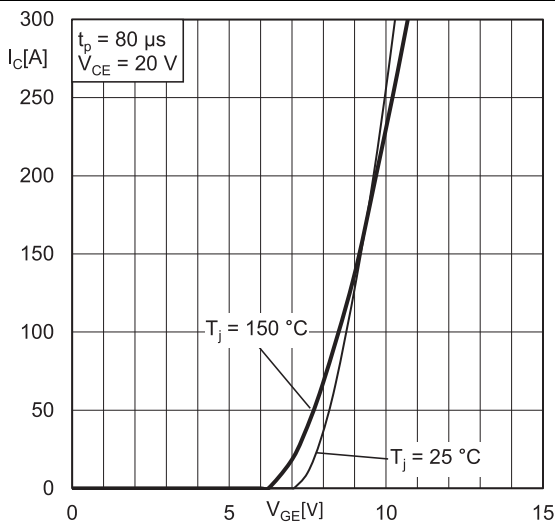


Fig. 17: Typ. IGBT2 transfer characteristic

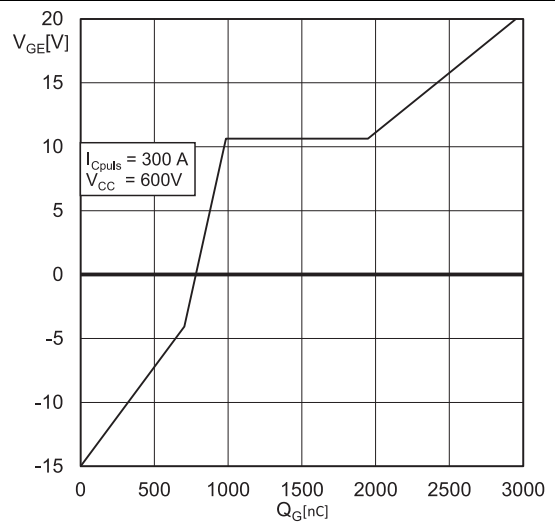


Fig. 18: Typ. IGBT2 gate charge characteristic

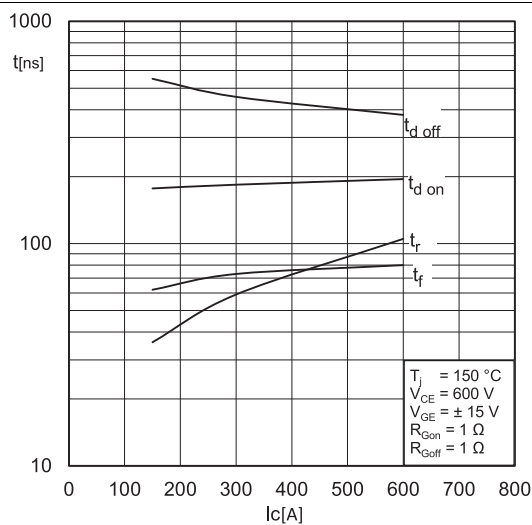


Fig. 19: Typ. IGBT2 switching times vs.  $I_c$

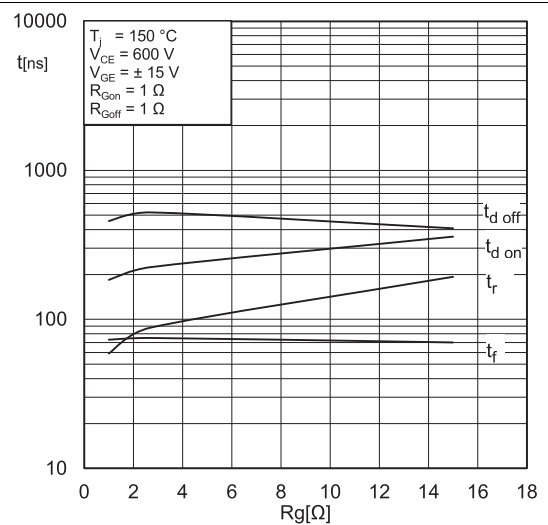


Fig. 20: Typ. IGBT2 switching times vs. gate resistor  $R_G$

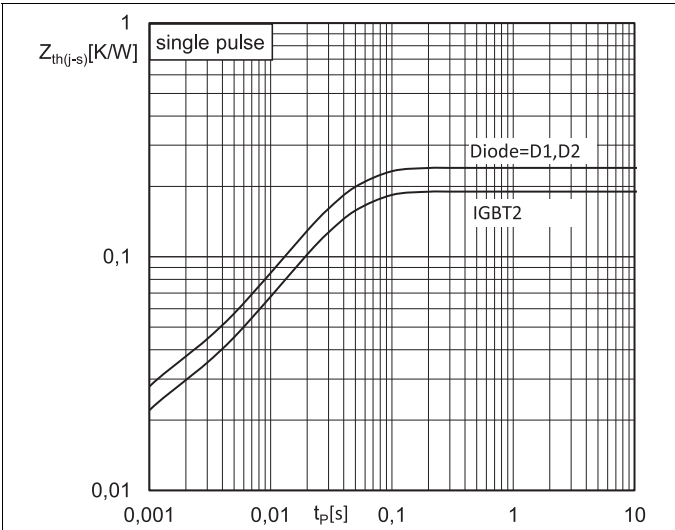


Fig. 21: Transient thermal impedance of IGBT2, Diode1 & Diode2

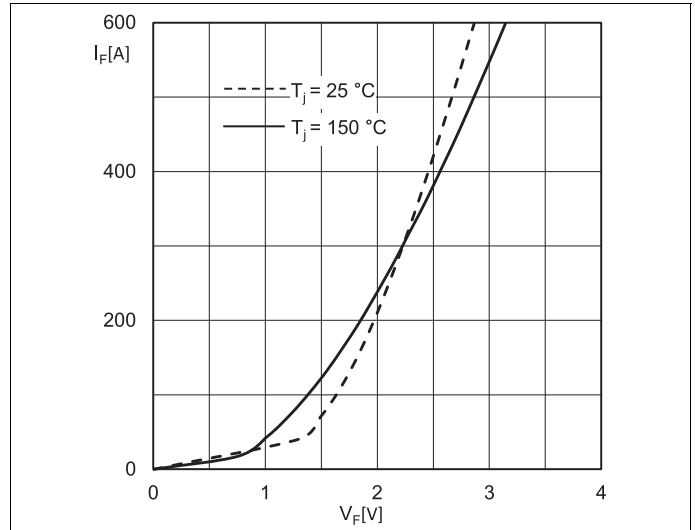
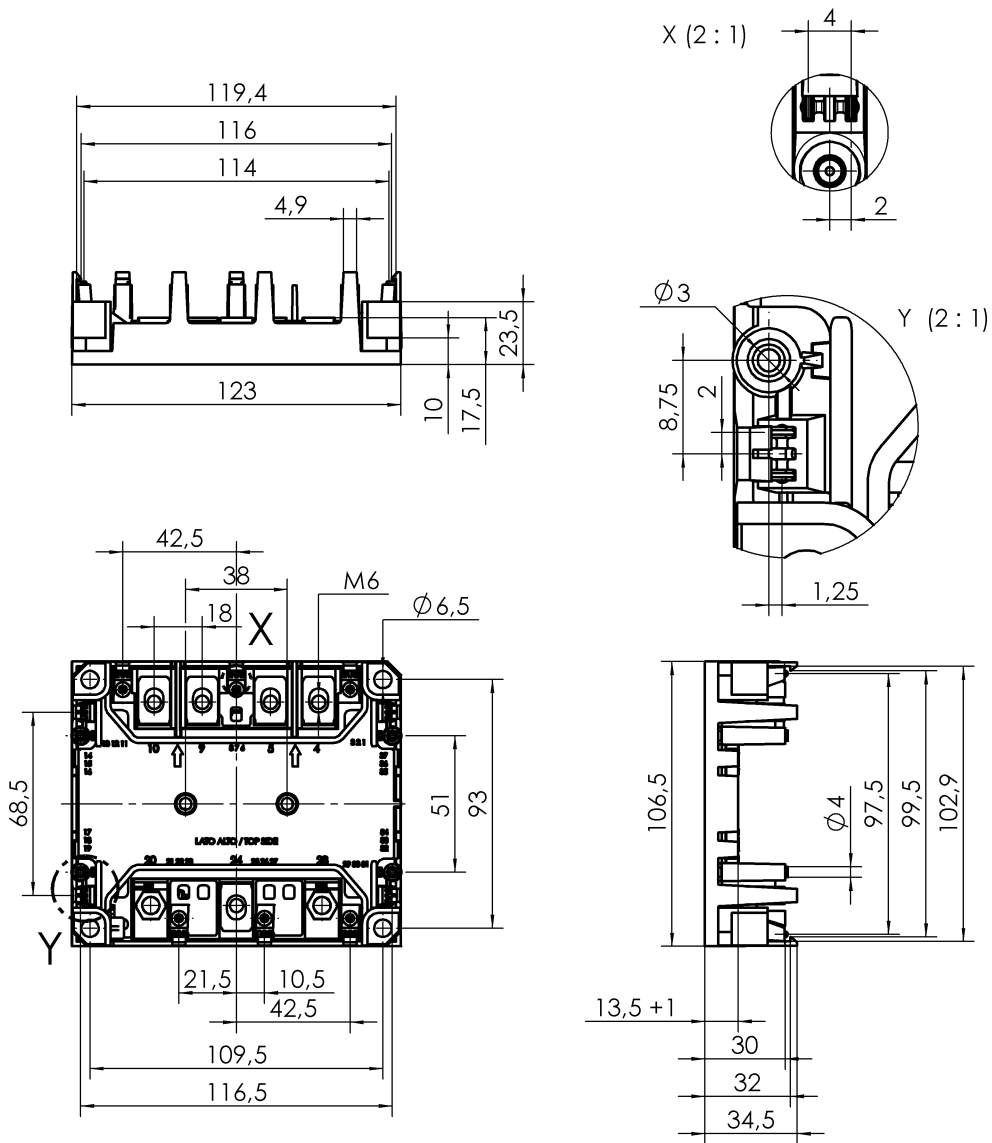


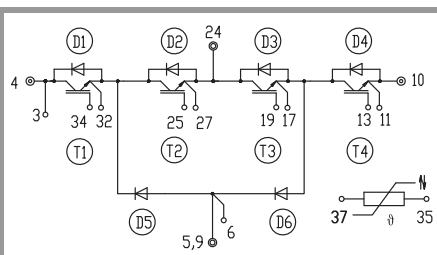
Fig. 22: Typ. Diode1 & Diode2 forward characteristic, incl.  $R_{CC+EE'}$



# SKiM301MLI12E4



SKiM 4



MLI

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

## **\*IMPORTANT INFORMATION AND WARNINGS**

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